				Complete if Known		
				Application Number	10/560,488	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (use as many sheets as necessary)			Ε	Filing Date	December 12, 2005	
			Γ	First Named Inventor	Gerald Lucovsky	
				Confirmation No.	3119	
				Examiner Name	Benjamin P. Sandvik	
Sheet	A1	of	A1	Attorney Docket Number	5051-639	

U.S. PATENTS AND PATENT PUBLICATIONS							
Examiner Initials*	Cite No.	U.S. Patent		Name of Patentee or Applicant of Cited  Document	Date of Publication of Cited Document		
		Number	Kind Code (if known)	Document	MM-DD-YYYY		
	1.	2002/0197789	A1	Buchanan et al;	12/26/2002		

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Examiner Initials*	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of	Translation
		Office	Number	Kind Code (if known)		Cited Document MM-DD-YYYY	
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		OTHER NON PATENT LITERATURE DOCUMENTS	T
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	'
	2.	Woo Sik Kim: Ferroelectric-gate field effect transistors using Nd₂Ti₂O <sub>7</sub> /Y₂O <sub>3</sub> /Si structures; Thin Solid Films 398-399 (2001) 663-667.	
	3.	Seung-Gu Lim; Dielectric functions and optical bandgaps of high-K dielectrics for metal-oxide- semicondutor field-effect transistors by far ultraviolet spectroscopic ellipsometry; Journal of Applied Physics, Volume: 91, Number 7, pp 4500-4505 (April 1, 2002).	
	4.	J.K. Yamamoto; <i>Microwave dielectric properties of layered perovskite A₂B₂O<sub>7</sub> single-crystal fibers</i> ; <i>Elsevier Science Publishers B.V. (North-Holland (1991) Material Letters No. 11/12 pp 497-500.</i>	
	5.	European communication with European Search Report for Application No. 04776548.2 – 1235 PCT/US2004018863, dated 5-6-2008.	

Examiner Signature	Date Considered	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.